

H1M120F030

Silicon Carbide MOSFET
N-CHANNEL ENHANCEMENT MODE

Features

- Low On-Resistance and High Current Density
- Low Capacitance for High Frequency Operation
- Ultra-high Avalanche Ruggedness
- Positive Temperature Coefficient Device
- AEC-Q101 Qualified
- RoHS Compliant and Halogen Free

Benefits

- Higher System Efficiency
- Increase Parallel Device Convenience
- Capable of 175°C High T_j Application
- Allow High Frequency Operation
- Realize Compact and Lightweight Systems

Applications

- Switching Mode Power Supply
- DC/DC Converters, UPS, and PFC
- EV Charging Station
- Motor Drives
- Power Inverters
- Solar/Wind Renewable Energy

Absolute Maximum Ratings ($T_c = 25^\circ\text{C}$ unless otherwise specified)

| Parameter | Symbol | Test Conditions | Value | Unit |
|--------------------------------|----------------|---|------------|------------------|
| Drain – Source Voltage | $V_{DS,max}$ | $V_{GS}=0V, I_{DS}=100\mu A$ | 1200 | V |
| Continuous Drain Current | I_D | $V_{GS}=20V, T_c=25^\circ\text{C}$ | 78 | A |
| | | $V_{GS}=20V, T_c=110^\circ\text{C}$ | 53 | |
| Pulse Drain Current | $I_{D,pulse}$ | t_{PW} limitation per Fig.15 | 349 | |
| Avalanche energy, Single Pulse | E_{AS} | $V_{DD}=100V, I_D=14A$ | 2500 | mJ |
| Power Dissipation | P_D | $T_c=25^\circ\text{C}$ | 375 | W |
| Recommend Gate Source Voltage | $V_{GS,op}$ | Static, recommended DC operating values | -5 to 20 | V |
| Maximum Gate Source Voltage | $V_{GS,max}$ | Transient operating limit (AC $f > 1\text{Hz}$, duty cycle $< 1\%$) | -10 to 25 | |
| Junction & Storage Temperature | T_j, T_{stg} | | -55 to 175 | $^\circ\text{C}$ |
| Soldering Temperature | T_L | | 260 | |
| Mounting Torque | M_D | M3 or 6-32 screw | 1.0 | Nm |

Thermal Resistance

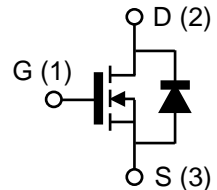
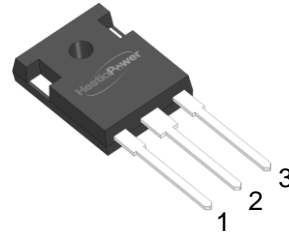
| Parameter | Symbol | Min. | Typ. | Max. | Unit |
|--------------------------------------|-----------------|------|------|------|--------------------|
| Thermal Resistance, Junction to Case | $R_{\theta,jc}$ | | 0.4 | | $^\circ\text{C/W}$ |

Product Summary

| | |
|--------------------------|-------|
| V_{DS} | 1200V |
| $I_D(@25^\circ\text{C})$ | 78A |
| $R_{DS(on)}$ | 30mΩ |



Circuit Diagram



| Part Number | Package | Marking |
|-------------|-----------|------------|
| H1M120F030 | TO-247-3L | H1M120F030 |

Description

The H1M120F030 1200V, 30mΩ silicon carbide power MOSFET is an N-channel enhancement mode device. Exploiting the outstanding wide bandgap material properties, this device shows high current density and great switching behavior. Thanks for the excellent thermal conductivity and many advantages of SiC, this device significantly improved in thermal capability and temperature independent switching behavior. With the high stability and reliability, this device also passes the qualification criteria based on AEC-Q101.

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit |
|--|---------------|--|-------------------------------------|------|------|---------|
| Drain-Source Breakdown Voltage | $V_{(BR)DSS}$ | $V_{GS}=0V, I_{DS}=100\mu A$ | 1200 | | | V |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS}=10V, I_{DS}=50mA$ | | 2.7 | | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS}=1200V, V_{GS}=0V$ | | <1 | 50 | μA |
| | | $V_{DS}=1200V, V_{GS}=0V$ $T_j=175^\circ\text{C}$ | | 10 | 500 | |
| Gate-Source Leakage Current | I_{GSS} | $V_{GS}=20V, V_{DS}=0V$ | | | 250 | nA |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS}=20V, I_{DS}=40A$ | | 30 | 40 | mΩ |
| | | $V_{GS}=20V, I_{DS}=40A$, $T_j=175^\circ\text{C}$ | | 54 | | |
| Transconductance | g_{fs} | $V_{DS}=15V, I_{DS}=40A$ | | 17 | | S |
| Input Capacitance | C_{iss} | $V_{GS}=0V, V_{DS}=800V$ $f=1MHz, V_{AC}=25mV$ | | 4909 | | pF |
| Output Capacitance | C_{oss} | | | 198 | | |
| Reverse Transfer Capacitance | C_{rss} | | | 34 | | |
| Effective Output Capacitance, Energy Related | $C_{o(er)}$ | | $V_{GS}=0V$, $V_{DS}=0$ to 800V | | 257 | |
| Effective Output Capacitance, Time Related | $C_{o(tr)}$ | $I_D=const.$, $V_{GS}=0V$, $V_{DS}=0$ to 800V | | 359 | | |
| Turn On Delay Time | $t_{d(on)}$ | $V_{DS}=800V, V_{GS}=-4/+20V$, $I_D=40A, R_L=20\Omega$, $R_{G(ext)}=2.7\Omega$ | | 31 | | ns |
| Rise Time | t_r | | | 55 | | |
| Turn Off Delay Time | $t_{d(off)}$ | | | 8 | | |
| Fall Time | t_f | | | 12 | | |
| C_{oss} Stored Energy | E_{oss} | $V_{GS}=0V, V_{DS}=800V$ $f=1MHz, V_{AC}=25mV$ | | 80.5 | | μJ |
| Turn-on Switching Energy | E_{on} | $V_{DS}=800V, V_{GS}=0/20V$, $I_D=40A$, | | 167* | | |
| Turn-off Switching Energy | E_{off} | $R_{G(ext)}=2.7\Omega$ | | 254* | | |
| Internal Gate Resistance | $R_{G(int.)}$ | $f=1MHz, V_{AC}=25mV$ | | 0.7 | | Ω |

*Based on the results of calculation, note that the energy loss caused by the reverse recovery of free-wheeling diode is not included in E_{on} .

Built-in SiC Diode Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

| Parameter | Symbol | Test Conditions | Typ. | Unit |
|----------------------------------|-----------|-----------------------------------|------|------|
| Inverse Diode Forward Voltage | V_{SD} | $V_{GS}=0V, I_{SD}=10A$ | 3.0 | V |
| Continuous Diode Forward Current | I_S | $V_{GS}=0V, T_c=25^\circ\text{C}$ | 50 | A |
| Reverse Recovery Time | t_{rr} | $V_{GS}=0V$, | 79 | ns |
| Reverse Recovery Charge | Q_{rr} | $I_{SD}=30A, V_{DS}=400V$, | 284 | nC |
| Peak Reverse Recovery Current | I_{rrm} | $di/dt=300A/\mu s$ | 6.8 | A |

Gate Charge Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

| Parameter | Symbol | Test Conditions | Value | Unit |
|-----------------------|----------|--|-------|------|
| Gate to Source Charge | Q_{GS} | $V_{DS}=800V$, $V_{GS}=-5/+20V$, $I_D=40A$ | 91 | nC |
| Gate to Drain Charge | Q_{GD} | | 88 | |
| Total Gate Charge | Q_G | | 305 | |
| Gate plateau voltage | V_{pl} | | 7.9 | V |

Typical Device Performance

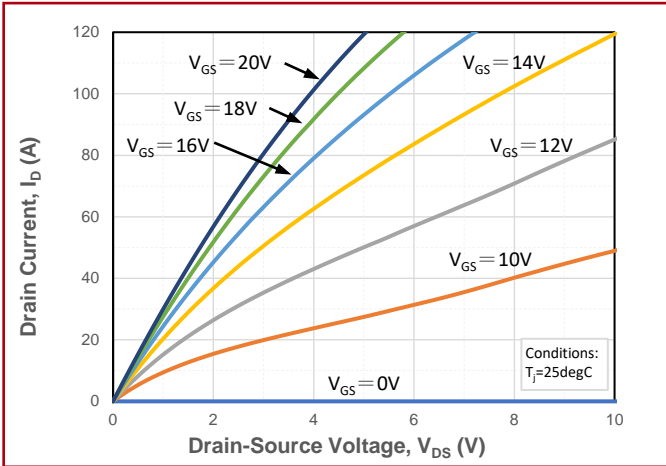


Fig.1 Forward Output Characteristics at $T_j = 25^\circ\text{C}$

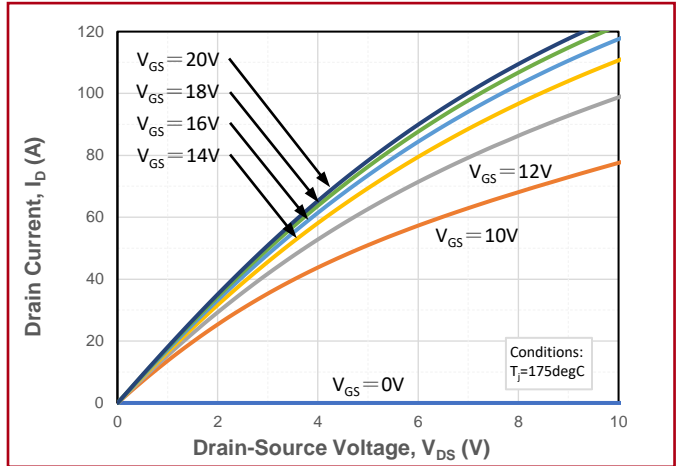


Fig.2 Forward Output Characteristics at $T_j = 175^\circ\text{C}$

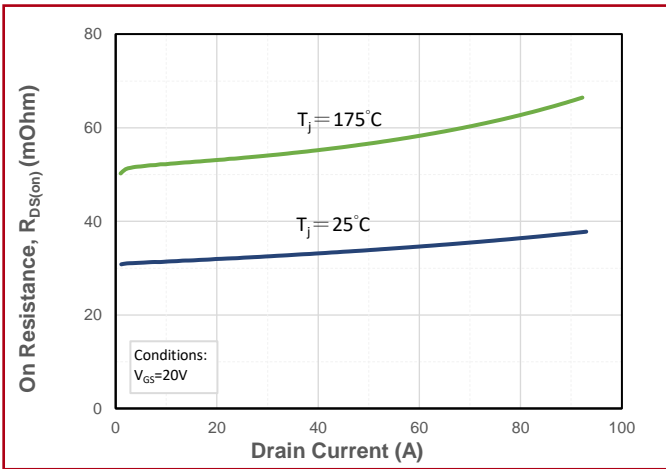


Fig.3 On-Resistance vs. Drain Current for Various T_j

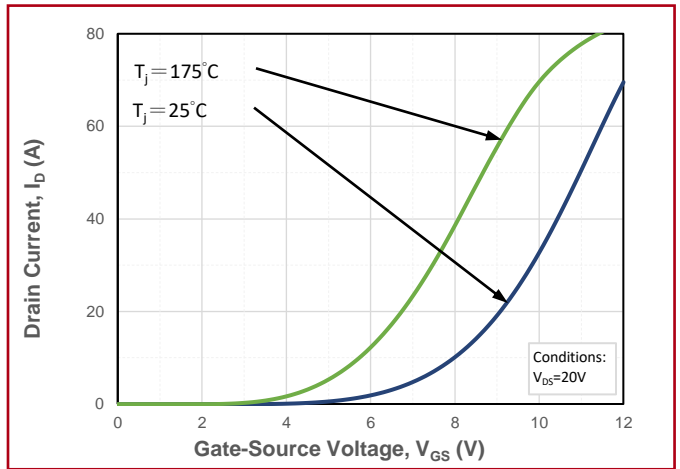


Fig.4 Transfer Characteristics for Various T_j

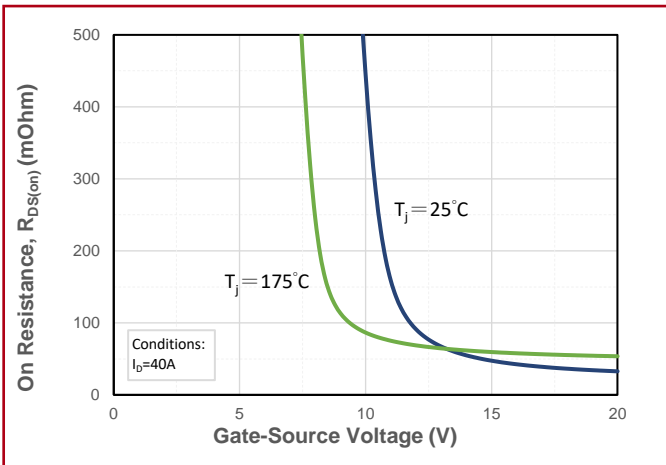


Fig.5 On-Resistance vs. Gate Voltage for Various T_j

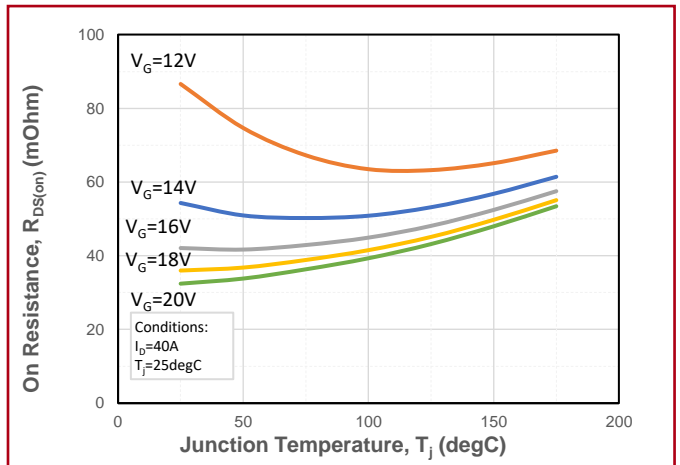


Fig.6 On-Resistance vs. Temperature for Various Gate Voltage

Typical Device Performance

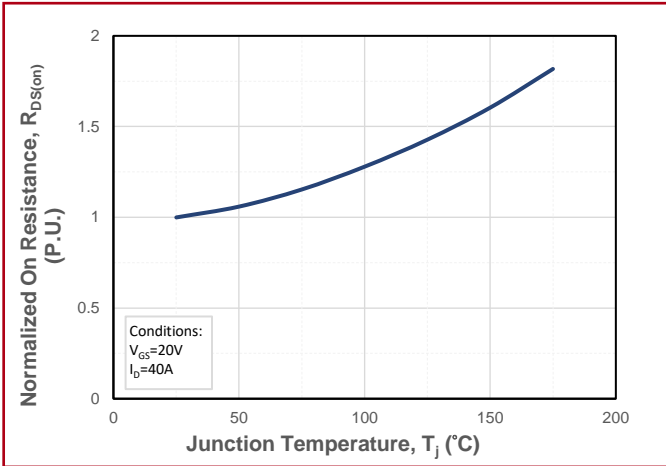


Fig.7 Normalized On-Resistance vs. Temperature

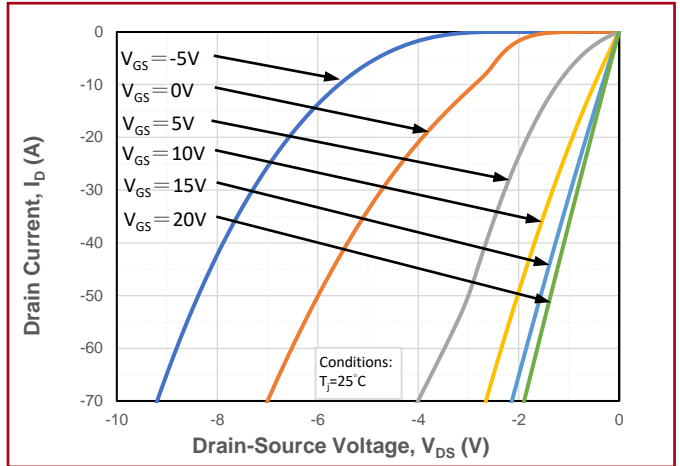


Fig.8 Reverse Output Characteristics at $T_j = 25^\circ C$

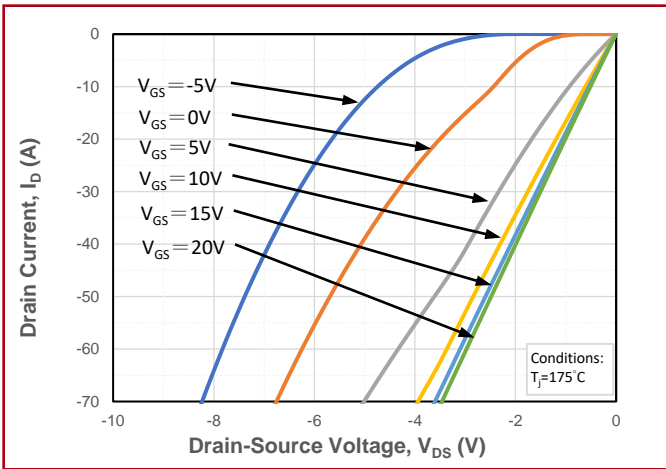


Fig.9 Reverse Output Characteristics at $T_j = 175^\circ C$

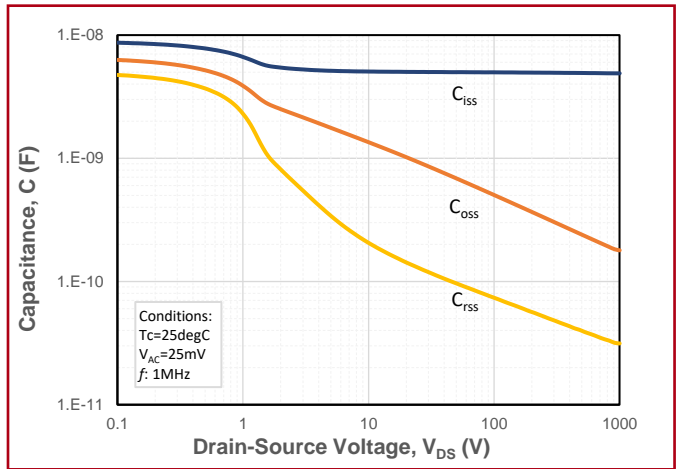


Fig.10 Capacitances vs. Drain to Source Voltage

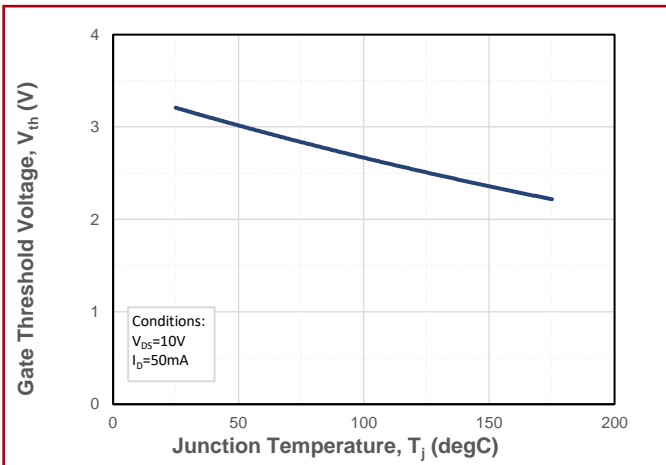


Fig.11 Threshold Voltage vs. Temperature

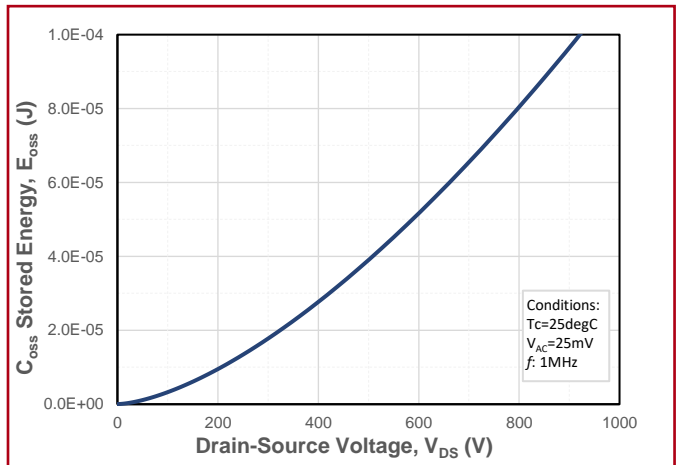


Fig.12 Output Capacitor Stored Energy

Typical Device Performance

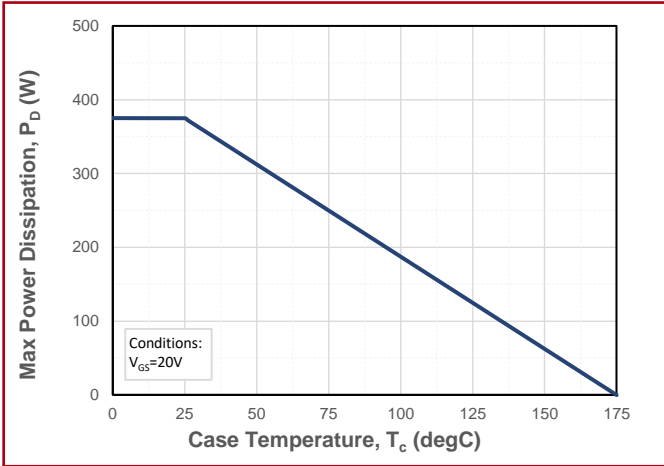


Fig.13 Maximum Power Dissipation Derating vs. Case Temperature

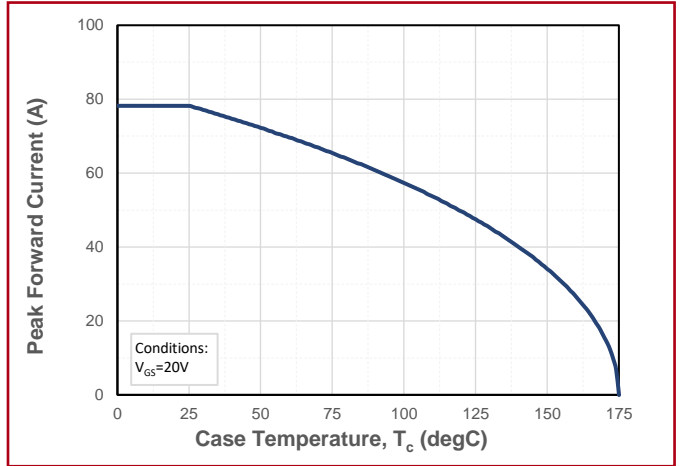


Fig.14 Drain Current Derating vs. Case Temperature

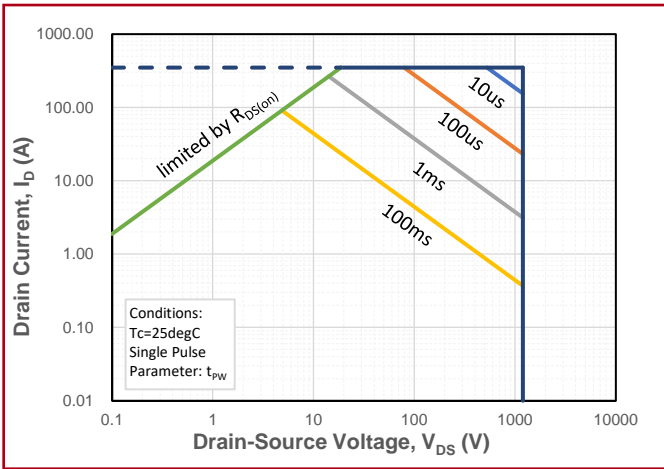


Fig.15 Safe Operating Area

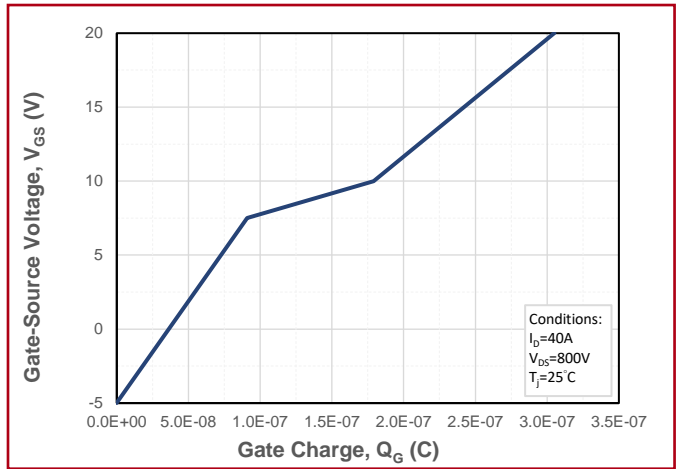


Fig.16 Gate Charge Characteristics

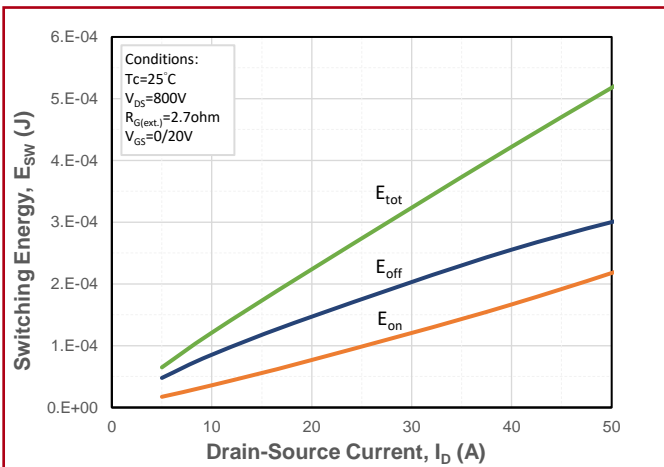


Fig.17 Clamped Inductive Switching Energy vs. Drain Current

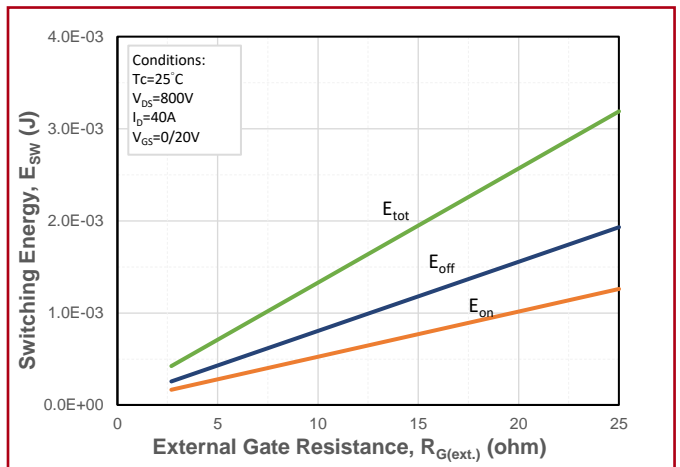


Fig.18 Clamped Inductive Switching Energy vs. External Gate Resistor ($R_{G(ext.)}$)

Typical Device Performance

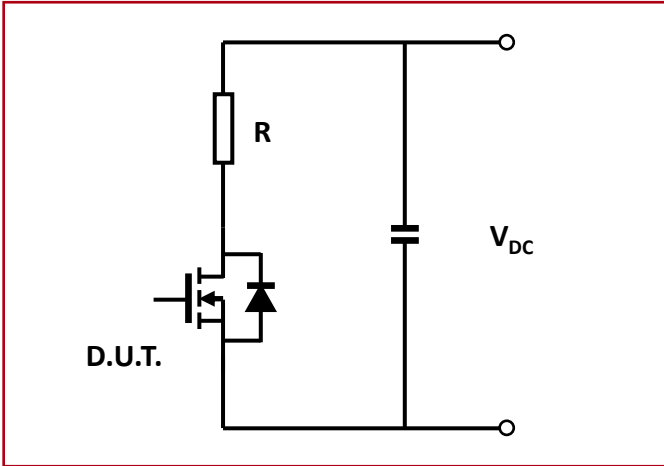


Fig.19 Schematic of Resistive Switching

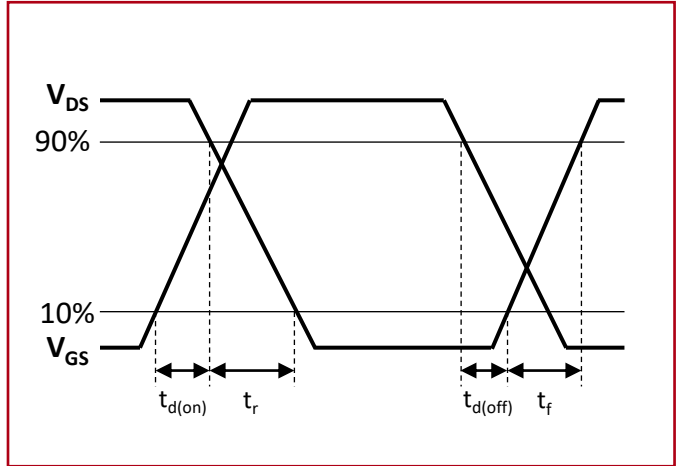


Fig.20 Switching Times Definition

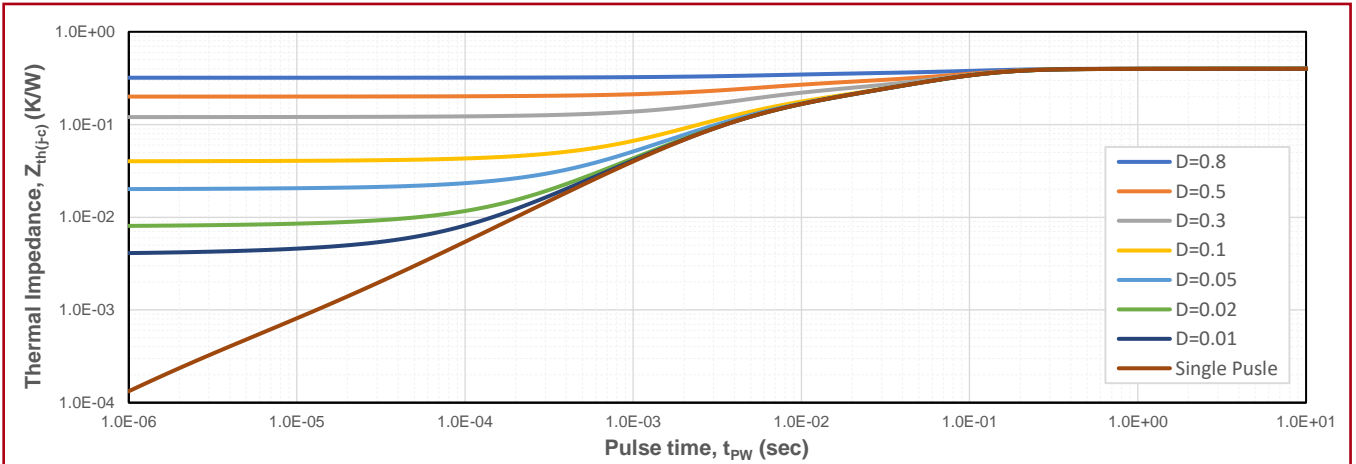


Fig.21 Transient Junction to Case Thermal Impedance

Naming Rule

H1 M 120 F 030

Generation

H1 = 1st Gen Discrete

Device Type

M = MOSFET J = J MOS

S = JBS diode

Breakdown Voltage

065 = 650V 170 = 1700V

120 = 1200V 330 = 3300V

Package

F = TO-247-3L B = TO-220-3L

T = TO-263-2L N = Bare Die

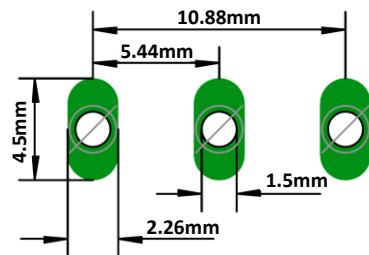
Typical On-Resistance

030 = 30mΩ 060 = 60mΩ 120 = 120mΩ

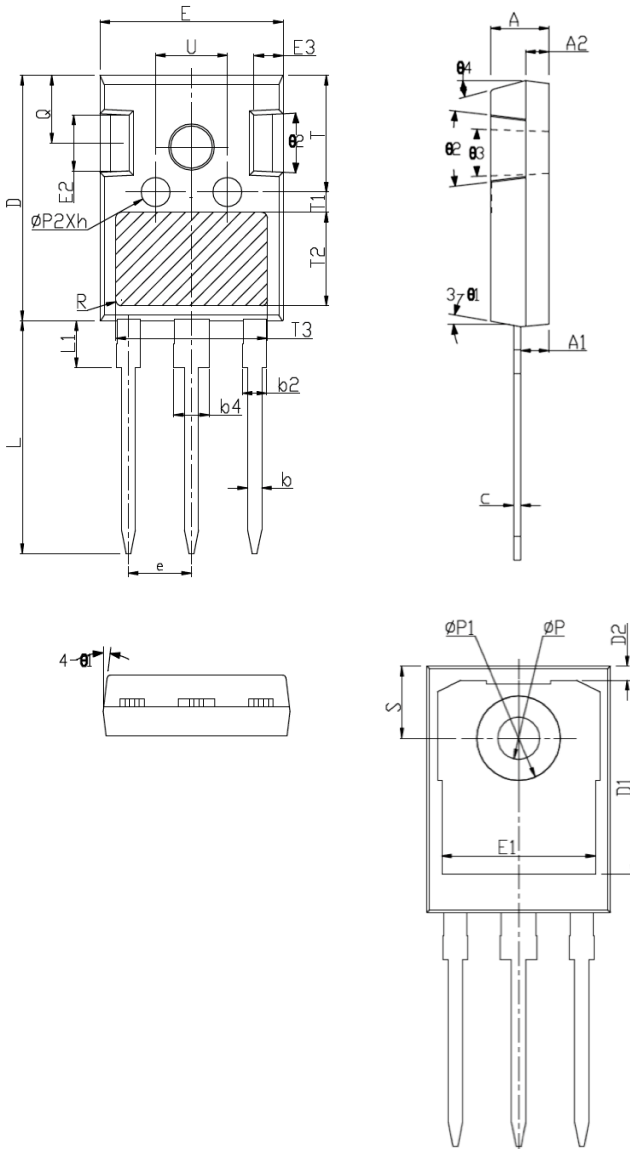
240 = 240mΩ

Recommended Solder Pad Layout

TO-247-3L



Package Dimensions



| Symbol | mm | | |
|------------|-----------|-------|-------|
| | Min. | Typ. | Max. |
| A | 4.75 | 5.00 | 5.25 |
| A1 | 2.16 | 2.41 | 2.66 |
| A2 | 1.85 | 2.00 | 2.15 |
| b | 1.11 | 1.21 | 1.35 |
| b2 | 1.90 | 2.01 | 2.25 |
| b4 | 2.90 | 3.01 | 3.25 |
| c | 0.51 | 0.61 | 0.75 |
| D | 20.60 | 21.00 | 21.40 |
| D1 | 16.15 | 16.55 | 16.95 |
| D2 | 1.00 | 1.20 | 1.40 |
| E | 15.50 | 15.80 | 16.10 |
| E1 | 13.00 | 13.30 | 13.60 |
| E2 | 4.70 | 5.00 | 5.30 |
| E3 | 2.25 | 2.50 | 2.75 |
| e | 5.44 BSC | | |
| h | 0.00 | 0.10 | 0.25 |
| L | 19.52 | 19.92 | 20.32 |
| L1 | - | - | 4.30 |
| ϕP | 3.35 | 3.60 | 3.85 |
| $\phi P1$ | - | - | 7.30 |
| $\phi P2$ | 2.25 | 2.50 | 2.75 |
| Q | 5.50 | 5.80 | 6.10 |
| S | 6.15 BSC | | |
| R | 0.50 REF | | |
| T | 9.70 | - | 10.30 |
| T1 | 1.65 REF | | |
| T2 | 8.00 REF | | |
| T3 | 12.80 REF | | |
| U | 5.90 | - | 6.50 |
| $\theta 1$ | 4° | 7° | 10° |
| $\theta 2$ | 2° | 5° | 8° |
| $\theta 3$ | 1° | - | 2° |
| $\theta 4$ | 10° | 15° | 20° |

Notes

- The information provided herein is subject to change without notice.
- For other information that does not show on this datasheet, please contact us for inquiry.